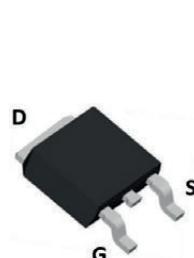
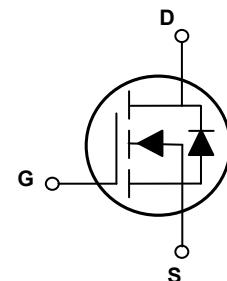


## Main Product Characteristics

$V_{(BR)DSS}$	1000V
$R_{DS(ON)}$	5.8Ω (Max.)
$I_D$	3A



TO-252 (DPAK)



Schematic Diagram



## Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery

## Description

The GSJD3N100 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supplies and a wide variety of other applications.

## Absolute Maximum Ratings ( $T_C=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Max.	Unit
Drain-Source Voltage	$V_{DS}$	1000	V
Gate-Source Voltage	$V_{GS}$	$\pm 30$	V
Continuous Drain Current <sup>1</sup>	$I_D$	3	A
$T_C=100^\circ\text{C}$		1.8	A
Pulsed Drain Current <sup>2</sup>	$I_{DM}$	12	A
Single Pulsed Avalanche Energy <sup>3</sup>	$E_{AS}$	31	mJ
Peak Diode Recovery $dv/dt$ <sup>4</sup>	$dv/dt$	5	V/ns
Power Dissipation ( $T_C=25^\circ\text{C}$ )	$P_D$	80	W
Power Dissipation Derating Factor Above 25°C		0.64	W/°C
Thermal Resistance, Junction to Case	$R_{\theta JC}$	1.56	°C/W
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	53	°C/W
Operating and Storage Temperature Range	$T_J/T_{STG}$	-50 to +150	°C
Max Lead Temperature for Soldering Purpose	$T_L$	260	°C

**Electrical Characteristics** ( $T_C=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
<b>On / Off Characteristics</b>						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_D=250\mu\text{A}$	1000	-	-	V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}}=1000\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	$\mu\text{A}$
		$V_{\text{DS}}=800\text{V}, T_J=125^\circ\text{C}$	-	-	50	
Gate to Body Leakage Current	$I_{\text{GSS}}$	$V_{\text{GS}}=\pm 30\text{V}$	-	-	$\pm 100$	nA
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_D=250\mu\text{A}$	2.8	3.8	4.8	V
Static Drain-Source On-Resistance <sup>3</sup>	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_D=1.5\text{A}$	-	-	5.8	$\Omega$
<b>Dynamic and Switching Characteristics</b>						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V}, f=1.0\text{MHz}$	-	618	-	pF
Output Capacitance	$C_{\text{oss}}$		-	49	-	
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	2.7	-	
Total Gate Charge	$Q_g$	$V_{\text{DD}}=800\text{V}, I_D=3\text{A}, V_{\text{GS}}=10\text{V}$	-	15.2	-	nC
Gate-Source Charge	$Q_{\text{gs}}$		-	3.94	-	
Gate-Drain ("Miller") Charge	$Q_{\text{gd}}$		-	6.06	-	
Turn-On Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=500\text{V}, I_D=3\text{A}, R_G=25\Omega, V_{\text{GS}}=10\text{V}$	-	14.9	-	nS
Turn-On Rise Time	$t_r$		-	20.5	-	
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	40.7	-	
Turn-Off Fall Time	$t_f$		-	73.8	-	
Gate Resistance	$R_g$	$V_{\text{DS}}=0\text{V}$	-	2.6	-	$\Omega$
<b>Source-Drain Ratings and Characteristics</b>						
Maximum Continuous Drain to Source Diode Forward Current	$I_s$	Integral reverse p-n junction diode in the MOSFET	-	-	3	A
Maximum Pulsed Drain to Source Diode Forward Current	$I_{\text{SM}}$		-	-	12	A
Drain to Source Diode Forward Voltage	$V_{\text{SD}}$	$V_{\text{GS}}=0\text{V}, I_{\text{SD}}=3\text{A}, T_J=25^\circ\text{C}$	-	-	1.3	V
Reverse Recovery Time	$T_{\text{rr}}$	$V_{\text{GS}}=0\text{V}, I_s=3\text{A}, \text{di/dt}=100\text{A}/\mu\text{s}$	-	470	-	nS
Reverse Recovery Charge	$Q_{\text{rr}}$		-	2.5	-	$\mu\text{C}$
Reverse Recovery Charge	$Q_{\text{rr}}$	$I_s=3\text{A}, \text{di/dt}=100\text{A}/\mu\text{s}$	-	10.5	-	$\mu\text{C}$

Notes:

1. Drain current is limited by maximum junction temperature.
2. Repetitive rating: pulse width limited by junction temperature.
3.  $L=10\text{mH}, I_{\text{AS}}=2.5\text{A}, V_{\text{DD}}=50\text{V}, R_G=25\Omega$ , starting at  $T_J=25^\circ\text{C}$ .
4.  $I_{\text{SD}} \leq I_D, \text{di/dt}=100\text{A}/\mu\text{s}, V_{\text{DD}} \leq BV_{\text{DSS}}$ , starting at  $T_J=25^\circ\text{C}$ .

## Typical Electrical and Thermal Characteristic Curves

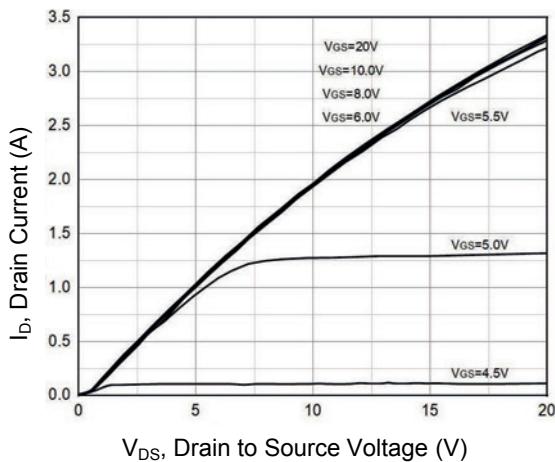


Figure 1. Output Characteristics

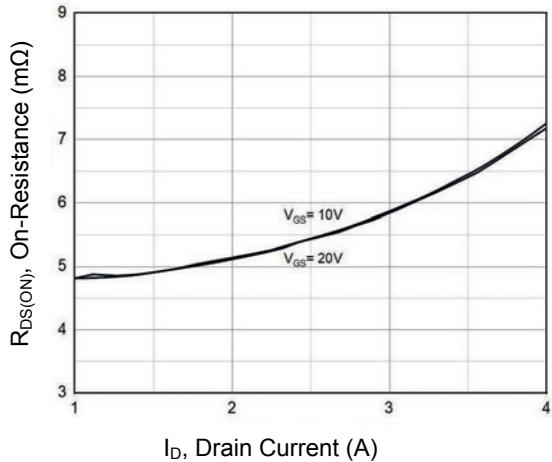


Figure 2.  $R_{DS(on)}$  vs. Drain Current

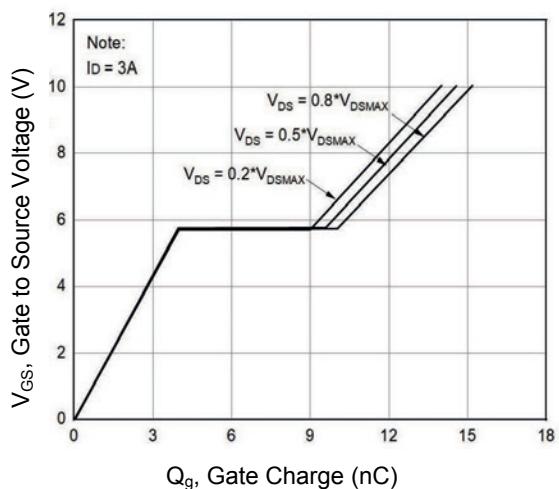


Figure 3. Gate Charge Characteristics

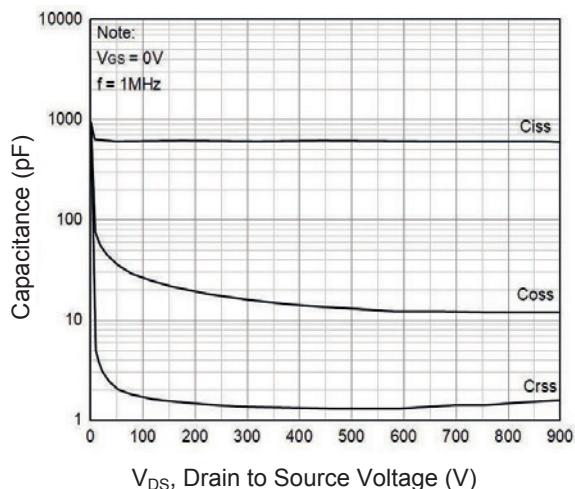


Figure 4. Capacitance Characteristics

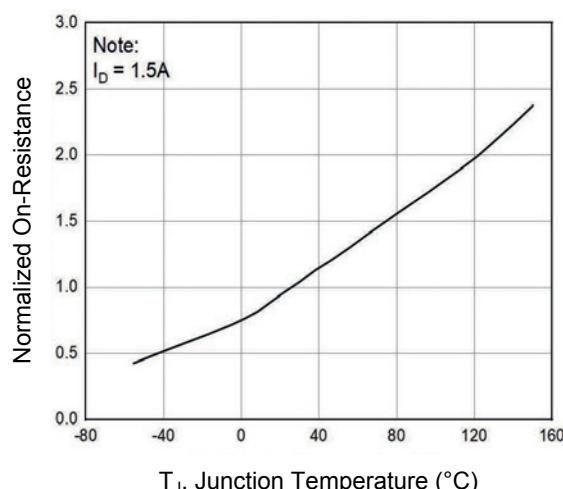


Figure 5. Normalized  $R_{DS(on)}$  vs.  $T_J$

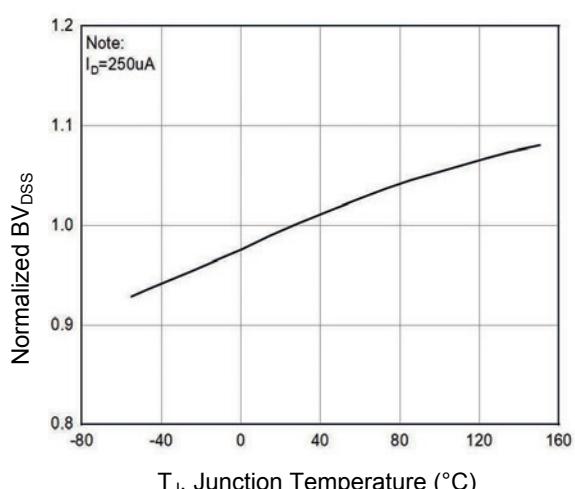


Figure 6. Normalized  $BV_{DSS}$  vs.  $T_J$

## Typical Electrical and Thermal Characteristic Curves

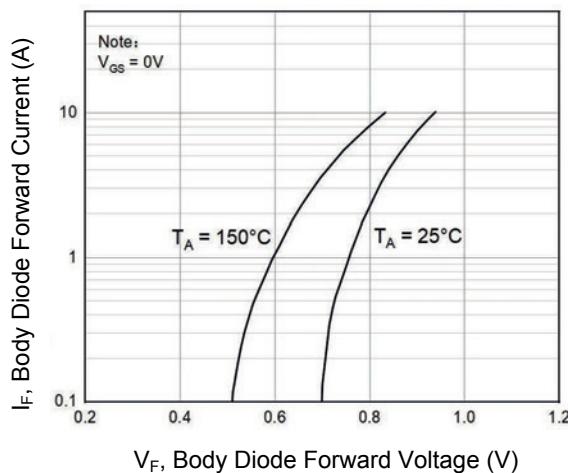


Figure 7. Body Diode Characteristics

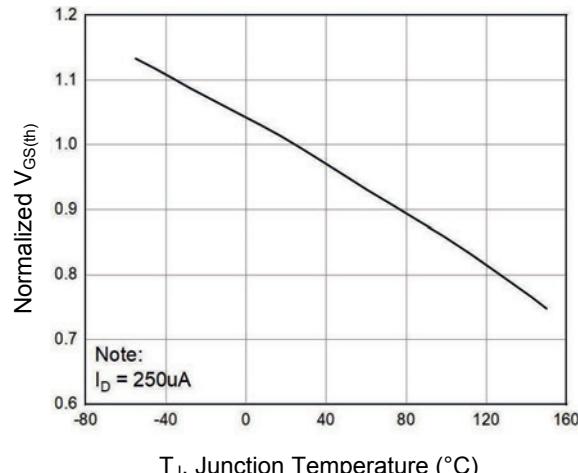


Figure 8. Normalized  $V_{GS(th)}$  vs.  $T_J$

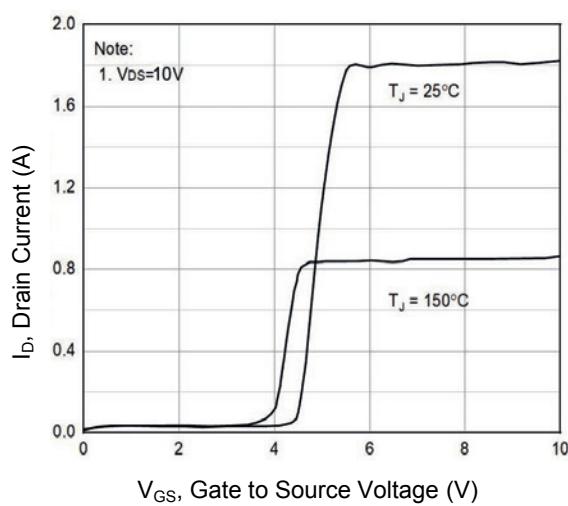


Figure 9. Transfer Characteristics

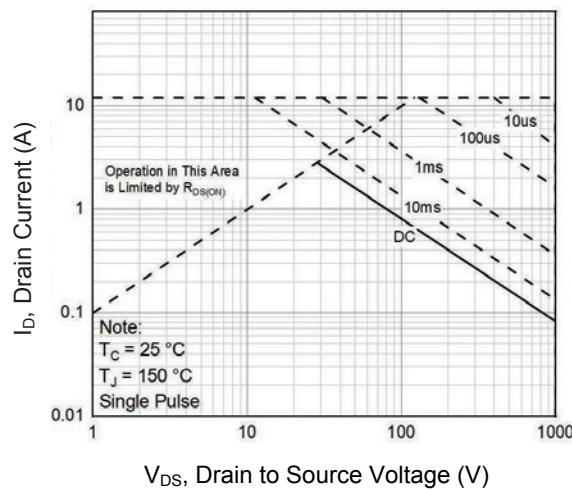


Figure 10. Safe Operation Area

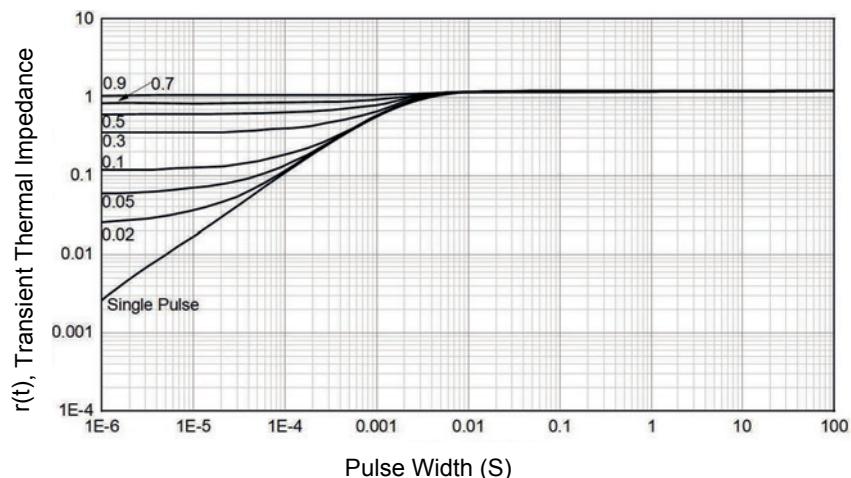
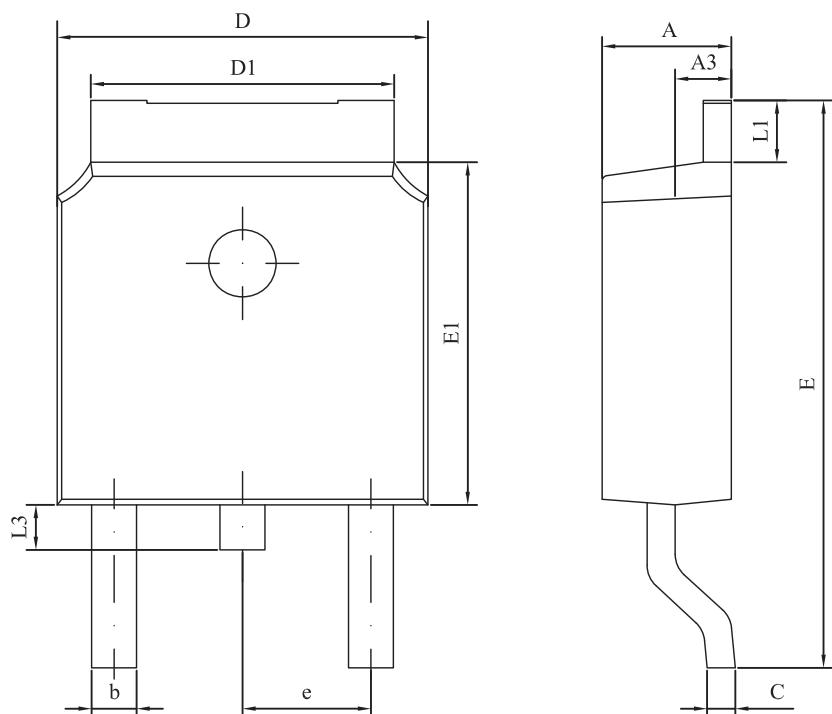


Figure 11. Transient Thermal Impedance

### Package Outline Dimensions TO-252 (DPAK)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.15	2.40	0.085	0.094
A3	0.90	1.10	0.035	0.043
b	0.50	0.90	0.020	0.035
C	0.40	0.65	0.016	0.026
D	6.30	6.90	0.248	0.272
D1	4.95	5.50	0.195	0.217
E	9.40	10.41	0.370	0.410
E1	5.90	6.30	0.232	0.248
e	2.286 BSC		0.090 BSC	
L1	0.89	1.27	0.035	0.050
L3	0.60	1.10	0.024	0.043

### Order Information

Device	Package	Marking	Carrier	Quantity
GSJD3N100	TO-252 (DPAK)	D3N100	Tape & Reel	2,500 Pcs / Reel

For more information, please contact us at: [inquiry@goodarksemi.com](mailto:inquiry@goodarksemi.com)